

Substitute for form 1449/PTO  <b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  <i>(Use as many sheets as necessary)</i>			<b>Complete If Known</b>		
			Application Number	10/676,680-Conf. #8216	
			Filing Date	October 1, 2003	
			First Named Inventor	Gail A. Alverson	
			Art Unit	2195	
			Examiner Name	E. C. Wai	
Sheet	1	of	1	Attorney Docket Number	324758001US4

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. <sup>1</sup>	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code <sup>2</sup> (if known)			
/EW/		US-6,219,690	04-17-2001	Slingwine et al.	
/EW/		US-6,529,958	03-04-2003	Oba et al.	
/EW/		US-5,778,230	07-07-1998	Wimble et al.	
/EW/		US-6,223,202	04-24-2001	Bayeh	
/EW/		US-5,740,413	04-14-1998	Alpert et al.	
/EW/		US-5,257,358	10-26-1993	Cohen	
/EW/		US-5,197,138	03-23-1993	Hobbs et al.	
/EW/		US-5,774,358	06-30-1998	Shrote	
/EW/		US-5,621,886	04-15-1997	Alpert et al.	
/EW/		US-20020103847-A1	08-01-2002	Potash	

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Examiner Signature	/Eric Wai/	Date Considered	06/11/2007
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/EW/		US-6,282,638	08-28-2001	Dowling	
/EW/		US-6,466,898	10-15-2002	Chan	
/EW/		US-6,470,376	10-22-2002	Tanaka et al.	

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/EW/		Silberschatz et al., "Operating System Concepts," Fifth Edition, John Wiley & Sons, Inc., 1998, page 103.	

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				Art Unit	2195
				Examiner Name	LILIAN VO
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/EW/		US-6,195,676-B1	02-27-2001	Spix et al.	
/EW/		US-6,487,590-B1	11-26-2002	Foley et al.	
/EW/		US-6,594,698-B1	07-15-2003	Chow et al.	
/EW/		US-6,622,155-B1	09-16-2003	Haddon et al.	
/EW/		US-6,785,887-B2	08-31-2004	Armstrong et al.	

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			Art Unit	2127	
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/EW/		US-5,179,702	01-12-1993	Spix et al.	
/EW/		US-5,485,626-B1	01-16-1996	Lawlor et al.	
/EW/		US-5,524,250	06-04-1996	Chesson et al.	
/EW/		US-5,526,521	06-11-1996	Fitch et al.	
/EW/		US-5,668,993	09-16-1997	Peters et al.	
/EW/		US-6,003,066	12-14-1999	Ryan et al.	
/EW/		US-6,016,542	01-18-2000	Gottlieb et al.	
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/EW/		US-6,105,051	08-15-2000	Borkenhagen et al.	
/EW/		US-6,212,544-B1	04-03-2001	Borkenhagen et al.	
/EW/		US-6,233,599-B1	05-15-2001	Nation et al.	
/EW/		US-6,272,520-B1	08-07-2001	Sharangpani et al.	
/EW/		US-6,298,370-B1	10-02-2001	Tang et al.	
/EW/		US-6,505,229-B1	01-07-2003	Turner et al.	
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/EW/		US-6,567,839-B1	05-20-2003	Borkenhagen et al.	
/EW/		US-6,631,425-B1	10-07-2003	Helland et al.	
/EW/		US-6,766,515-B1	07-20-2004	Bitar et al.	

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/EW/		US-6,584,489-B1	06-24-2003	Jones et al.	
/EW/		US-6,560,626-B1	05-06-2003	Hogle et al.	

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				Express Mail No.	EV335524911US
				Application Number	
				Confirmation Number	
				Filing Date	Herewith
				First Named Inventor	Gall A. Alverson
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/EW/		4,819,234		Huber	4/4/89	
/EW/		4,872,167		Maezawa et al.	10/3/89	
/EW/		5,168,554		Luke	12/1/92	
/EW/		5,301,325		Benson	4/5/94	
/EW/		5,333,280		Ishikawa et al.	7/26/94	
/EW/		5,450,575		Sites	9/12/95	
/EW/		5,504,932		Vassiliadis et al.	4/2/96	
/EW/		5,533,192		Hawley et al.	7/2/96	
/EW/		5,557,761		Chan	9/17/96	
/EW/		5,564,051		Halliwell et al.	10/8/96	
/EW/		5,581,764		Fitzgerald et al.	12/3/96	
/EW/		5,594,864		Trauben	1/14/97	
/EW/		5,598,560		Benson	1/28/97	
/EW/		5,632,032		Ault et al.	5/20/97	
/EW/		5,652,889		Sites	7/29/97	
/EW/		5,712,996		Schepers	1/27/98	
/EW/		5,754,855		Miller et al.	5/19/98	
/EW/		5,768,591		Robinson	6/16/98	
/EW/		5,768,592		Chang	6/16/98	
/EW/		5,774,721		Robinson	6/30/98	
/EW/		5,787,245		You et al.	7/28/98	
/EW/		5,805,892		Nakajima	9/8/98	
/EW/		5,812,811		Dubey et al.	9/22/98	
/EW/		5,826,265		Van Huben et al.	10/20/98	
/EW/		5,867,643		Sutton	2/2/99	
/EW/		5,877,766		Bates et al.	3/2/99	
/EW/		5,887,166		Mallick et al.	3/23/99	
/EW/		5,901,315		Edwards et al.	5/4/99	
/EW/		5,903,730		Asai et al.	5/11/99	
/EW/		5,913,925		Kahle et al.	6/22/99	
/EW/		5,953,530		Rishi et al.	9/14/99	
/EW/		5,961,639		Mallick et al.	10/5/99	
/EW/		5,966,539		Srivastava	10/12/99	

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/EW/		5,978,902		Mann	11/2/99	
/EW/		6,002,872		Alexander III et al.	12/14/99	
/EW/		6,002,879		Radigan et al.	12/14/99	
/EW/		6,009,269		Burrows et al.	12/28/99	
/EW/		6,029,005		Radigan	2/22/00	
/EW/		6,049,671		Slivka et al.	4/11/00	
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/EW/		6,059,840		Click, Jr.	5/9/00	
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		Office	NUMBER	Kind Code (if known)				
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				Group Art Unit	
Examiner Name					
Sheet	3	of	5	Attorney Docket No.	324758001US4

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